·	Application No.	Applicant(s)
Notice of Allowability	10/645,331	OZCAN ET AL.
	Examiner	Art Unit
	Sang Nguyen	2877
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	ears on the cover sheet with the co (OR REMAINS) CLOSED in this apport or other appropriate communication GHTS. This application is subject to and MPEP 1308.	plication. If not included will be mailed in due course. THIS
1. A This communication is responsive to <u>Terminal Disclaimer 1</u>	<u>10/25/05</u> .	
2. X The allowed claim(s) is/are 3-27 which have been renumbe	ered as indicate claim 1-25.	
<ul> <li>3. Acknowledgment is made of a claim for foreign priority unal and an All by Some* c) None of the:</li> <li>1. Certified copies of the priority documents have</li> </ul>	been received.	
2. Certified copies of the priority documents have	· · · · · · · · · · · · · · · · · · ·	
3. Copies of the certified copies of the priority doc	cuments have been received in this	national stage application from the
International Bureau (PCT Rule 17.2(a)).  * Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.  4. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give	ENT of this application. itted. Note the attached EXAMINER	'S AMENDMENT or NOTICE OF
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<ol> <li>CORRECTED DRAWINGS (as "replacement sheets") mus</li> <li>including changes required by the Notice of Draftspers</li> </ol>		948) attached
1) hereto or 2) to Paper No./Mail Date		- · · <b>, - · · · ·</b>
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the C	
Identifying indicia such as the application number (see 37 CFR 1, each sheet. Replacement sheet(s) should be labeled as such in the		
<ol> <li>DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT</li> </ol>	sit of BIOLOGICAL MATERIAL I FOR THE DEPOSIT OF BIOLOGIC	must be submitted. Note the AL MATERIAL.
		·
Attachment(s)	5 D Nation of laterace	Outont Application (DTO 452)
<ol> <li>Notice of References Cited (PTO-892)</li> <li>Dotice of Draftperson's Patent Drawing Review (PTO-948)</li> </ol>		Patent Application (PTO-152)
	Paper No./Mail Da	te
<ol> <li>Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 10/17/05</li> </ol>	98), 7. Examiner's Amendi	ment/Comment
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8.   Examiner's Statement	ent of Reasons for Allowance
oi biological material	9. Other  Grege Supervis	Totaley, Vr.

## **DETAILED ACTION**

## Terminal Disclaimer

The terminal disclaimer filed on 01/17/05 disclaiming the terminal portion of any patent granted on this application which would extend beyond the expiration date of 6,856,393 has been reviewed and is accepted. The terminal disclaimer has been recorded.

## Allowable Subject Matter

Claims 3-27 are allowed.

The following is an examiner's statement of reasons for allowance:

As to independent claim 1 is allowable over the prior art for at least the reason that the prior art of record, taken alone or in combination, fails discloses or render obvious method of measuring a nonlinearity profile of a sample comprising all the specific elements with the specific combination including of measuring a Fourier transform magnitude of the composite nonlinearity profile and calculating the sample nonlinearity profile using the Fourier transform magnitude of the composite nonlinearity profile in combination with the rest of the limitation of claim 1.

As to independent claims 6-7 are allowable over the prior art for at least the reason that the prior art of record, taken alone or in combination, fails discloses or render obvious method of measuring a nonlinearity profile of a sample comprising all the specific elements with the specific combination including of measuring a Fourier transform magnitude of the first composite nonlinearity profile, forming a second composite sample having a second composite nonlinearity profile which is inequivalent

to the first composite nonlinearity profile by placing the sample and the reference material proximate to one another in a second configuration with the sample line substantially collinear with the reference line, measuring a Fourier transform magnitude of the second composite nonlinearity profile, and calculating the sample nonlinearity profile using the Fourier transform magnitudes of the sample nonlinearity profile, the reference nonlinearity profile, the first composite nonlinearity profile, and the second composite nonlinearity profile in combination with the rest of the limitation of claims 6-7.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance.".

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Examiner Sang Nguyen whose telephone number (571)-272-2425. The Examiner can normally be reached on Monday through Friday From 9:30 AM to 6:30 PM.

If attempts to reach the Examiner by telephone are unsuccessful, the Examiner's Supervisor, Mr. Gregory J. Toatley, Jr., can be reached on (571) 272-2800 ext. 77. The fax number for the organization where this application or proceeding is assigned is (703) 872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Nguyen/sn

November 9, 2005

Gregory J. Voatley, Jr. Supervisory Patent Examiner

Technology Center 2800